Modeling time and spatial dependence of degradation processes through gamma processes

M.Oumouni<sup>1</sup>, F.Schoefs<sup>1</sup>, B. Castanier<sup>2</sup>

<sup>1</sup>Équipe Trust, Institut de Recherche en Génie Civil et Mécanique, Université Bretagne Loire <sup>2</sup>Laboratoire Angevin de Recherche en Ingénierie des Systèmes, Université Bretagne Loire

### Trust's simnar, September 2016





2 Gamma Process with random field rate

3 Quantities of Interest and parameters reference

# 4 Simulation results



Introduction

Gamma Process with random field rate Quantities of Interest and parameters reference Simulation results Conclusion

# Why spatial variability and uncertainty?

The degradation in the structure varies in space and in time Qualifies the non-homogeneity in the mechanical and physical properties. Uncertainty : the intrinsic aleatory of the material

### Source of spatial variability

- intrinsic aleatory of the composition
- the environmental conditions during the life of the structure (temperature, humidity, chloride penetration)
- the implementation conditions (workmanship : anisotropy and heterogeneity)
- It influences the predictions of degradation and the reliability of the structural component

#### Introduction

Gamma Process with random field rate Quantities of Interest and parameters reference Simulation results Conclusion

# Probabilistic approaches for modeling degradation process

- Physical model approach
  - Simulation of physical quantities varying in space and in time.
  - Transport equation with random coefficient and data (Stewart et all; Shinozuka et all,...)
  - Curse of dimensionality
  - Huge cost of the resolution (MC, Galerkin, Sparse grid)
- Meta-model approach (classical model)
  - Based on measurable quantities to fit the model
  - Stochastic process (Gamma process, Brownian motion,...)

#### Extension of the classical model

- Incorporate the spatial variability
- Predict the degradation evolution temporally and Spatially
- based on the classical temporal model (gamma process)
- Mathematical and numerical computation benefits
- 🗢 Spatio-temporal random field

# Gamma process

 $(X_t)$  is a Gamma process with parameter  $(\alpha, \beta) > 0$  ( $\alpha$  increasing function) if

- X<sub>0</sub> = 0 p.s
- X<sub>t</sub> has independent positive increments
- $X_{t+s} X_s \sim gamma(lpha(t+s) lpha(s), eta)$  (gamma distribution)
- $\alpha(\cdot)$  linear :  $X_t$  is stationary process
- $\alpha(\cdot)$  non-linear :  $X_t$  is non-stationary process

#### properties

- The mean  $\mu(t) = rac{lpha(t)}{eta}$  and variance  $\sigma = rac{lpha(t)}{eta^2}$
- Scaling  $\gamma X_t = Gamma(\alpha, \beta/\gamma)$
- Additivity  $Gamma(\alpha_1, \beta) + Gamma(\alpha_2, \beta) = Gamma(\alpha_1 + \alpha_2, \beta)$

• 
$$\mathbb{E}[\log(X_t)] = \psi(\alpha(t)) - \log(\beta)$$

•  $Var[log(X_t)] = \psi_1(\alpha(t))$ 

where  $\psi(r) = \frac{\Gamma'(r)}{\Gamma(r)}$  digamma function and  $\psi_1$  its derivative.

200

Spatio-temporal random field

A sequence of random variables which is indexed in spatio-temporal box

$$\{G(t,x); (t,x) \in \mathbb{R}^+ \times \mathbb{R}^d\}.$$

### Separable random field

- No interaction between time and space
- Widely used even in situations in which they are not always physically justifiable

#### two constructions

- G(t,x) = X(t) + Y(x)➡ additive field
- $\blacktriangleright$  multiplicative field G(t, x) = X(t)Y(x)

Everything else are non-separable random field

・ 同 ト ・ ヨ ト ・ ヨ ト

1

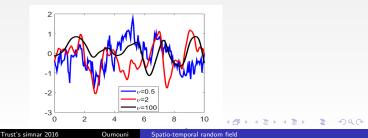
# Stationary gaussian random field

Y(x) is defined by the covariance of Matèrn model :

$$c(r) = \frac{\sigma^2 2^{\nu-1}}{\Gamma(\nu)} \left(\frac{\sqrt{2}\nu r}{lc}\right)^{\nu} \mathcal{K}_{\nu}\left(\frac{\sqrt{2}\nu r}{lc}\right)$$

- exponential ( $\nu = 0.5$ ),  $c(r) = \sigma^2 e^{-\frac{r}{t_c}}$
- <u>Gaussian</u>  $(\nu = \infty)$ ,  $c(r) = \sigma^2 e^{-\frac{r^2}{2k^2}}$

 $\sigma^2$  variance,  $\mathit{lc}$  correlation length,  $\mathcal{K}_\nu$  modified Bessel function,  $\nu>0$  smoothness parameter.



# Degradation model

 $X_t = Ga(lpha(t),\eta)$  Gamma process,  $Z(x) = e^{Y(x)}$  log-normal field,

$$\mathsf{G}_t(x) := \mathsf{X}_t \mathsf{Z}(x) \sim \mathsf{Ga}(lpha(t), \eta e^{-\mathsf{Y}(x)})$$

# Some raison for choosing log-normal distribution

- Products of positive independent random variables converges to a log-normal (CLM)
- Mathematical and statistical benefits in practice (ML, covariance)
- $Z \sim Z^{-1}$  thus  $G_t(x) \sim X_t/Z(x)$  in law.

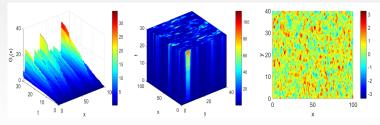


Figure – Stationary model, (left 1D, 2D middle). Gaussian field (right) = 🔍

Reliability result

# Methodology and approach

# Inference

- Spatial parameters :
  - $\sigma^2$  variance of Y $l_c$  correlation length  $\nu$  smoothness parameter
- Temporal parameters :  $\alpha(t)$  shape parameter.  $\eta = e^{\mu}$  deterministic scale.

# **Quantities of interest**

• marginal law de  $G_t$  and failure time

$$T = \inf_{t>0} \left( G_t(\cdot) \geq g_F \right).$$

residual life time

$$extsf{RL}_t( au) = \left( au > 0; \; extsf{G}_{t+ au} \geq extsf{g}_{ extsf{F}} | extsf{G}_t = extsf{g}_t 
ight)$$

### Method of inference

- Method of moments
- maximum likelihood method

#### Methodology

• Estimation using realisations of  $G_t$ 

(日)

• Estimation by quadrature

Quantities of Interest and parameters reference Simulation results

Reliability result

### Marginal density of $G_t(x)$

$$f_t(v) = \frac{\eta^{\alpha(t)} v^{(\alpha(t)-1)}}{\Gamma(\alpha(t))} \int_{\mathbb{R}} \exp\left(-v\eta \exp(\sigma y) + \alpha(t)\sigma y\right) \xi(y) dy.$$

where  $\xi$  is the density of gaussian random variable N(0,1)

$$f_t^m(z) := \frac{\eta^{\alpha(t)} z^{(\alpha(t)-1)}}{\Gamma(\alpha(t))} \sum_{j=1}^m \exp\left(-z\eta \exp(\sigma y_j) + \alpha(t)\sigma y_j\right).$$

 $\{y_j\}_{j=1}^m$  m Hermite's polynomial roots,  $\{w_j\}_{j=1}^m$  their weights. The order m is given by the stopped criterion,

$$|f_t^m - f_t^{m-1}| \le \epsilon,$$

where  $\epsilon > 0$  is a convenient threshold

Reliability result

#### failure distribution

• failure time distribution

$$F_T(t) \approx 1 - \int_0^{g_F} f_t^m(z) dz,$$

$$\tilde{F}_{\mathcal{T}}(t_i) = (MN_x)^{-1} \sum_{j,k}^{N_x,M} \mathbb{I}_{\{G_{t_i}^k(x_j) \ge g_F\}}.$$

where  $(G_{t_i}^k(x_j))$ ,  $i = 1, ..., N_t$ ,  $j = 1, ..., N_x$  realizations of G on the spatio-temporal box.

• Residual life distribution

$$P(RL_t > \tau) = \int_0^{g_F - g_t} \frac{u^{\delta_\tau \alpha - 1} g_t^{\alpha(t) - 1}}{B(\delta_\tau \alpha, \alpha(t))(u + g_t)^{(\alpha(\tau + t) - 1)}} \frac{f_{\tau + t}^m(u + g_t)}{f_t^m(g_t)} du$$

<ロト < 回 > < 回 > < 回 > < 回 > <</p>

э

# Inference Result (stationary case $\alpha(t) = \alpha t$ )

Method of moments

•  $\hat{\Upsilon}_Y$  is the experimental variogram of Y :

$$\min_{\sigma, lc, \nu > 0} \sum_{l=1}^{N_x} \left( \hat{\Upsilon}_Y(lh) + \sigma^2 cov_\nu(lh) - \sigma^2 \right)^2,$$

•  $\hat{m}_1$ ,  $\hat{m}_2$  are estimate of two first moments of  $\log(\delta G_t)$ , then :

$$\begin{pmatrix} \alpha \\ \eta \end{pmatrix} = \varphi^{-1} \begin{pmatrix} \hat{m}_1 \\ \hat{m}_2 \end{pmatrix}, \quad \text{où} \quad \varphi \begin{pmatrix} u \\ v \end{pmatrix} = \begin{pmatrix} \psi(u\tau) - \log(v) \\ \psi_1(u\tau)) + \sigma^2 \end{pmatrix}$$

Maximum pseudo-likelihood method

•  $\alpha$  et  $\beta$  maximize the pseudo-likelihood on the spatial grid

$$L(z) = \sum_{k=1}^{M} \sum_{j=1}^{N_t} \log\left(f_{\tau}^m(z_j^k)\right)$$

| $N_x = 40, \ N_y = 20$ |                            |                            | $N_x = 40, N_y = 20, N_t = 30$  |              |              |
|------------------------|----------------------------|----------------------------|---------------------------------|--------------|--------------|
| M                      | $\sigma^2$                 | l <sub>c</sub>             | M                               | α            | $\eta$       |
| 1                      | 0.638 <mark>(0.038)</mark> | 0.913(0.087)               | 1                               | 1.613(0.613) | 2.660(0.71)  |
| 10                     | 0.583(0.017)               | 1.06(0.06)                 | 10                              | 0.934(0.06)  | 1.833(0.134) |
| $N_x = 100, N_y = 40$  |                            |                            | $N_x = 100, N_y = 40, N_t = 30$ |              |              |
| M                      | $\sigma^2$                 | l <sub>c</sub>             | M                               | α            | $\eta$       |
| 1                      | 0.58(0.02)                 | 0.949(0.051)               | 1                               | 0.801(0.198) | 2.184(0.236) |
| 10                     | 0.606 <mark>(0.006)</mark> | 1.007 <mark>(0.007)</mark> | 10                              | 1.072(0.07)  | 2.123(0.175) |

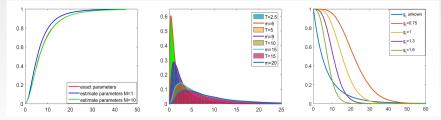


Figure - Failure distribution, marginal density, reliability and residual life

・ロト ・回ト ・ヨト ・ヨト

æ

#### Conclusion

- New degradation model which incorporate both hazards temporal and spatial
- Statistical analysis for assessing the law of the model
- Estimation of the quantities of interest for reliability analysis

#### Perspective

- Extension to bivariate and non-stationary model.
- Scale parameter as spatio-temporal field derived from mathématical models (EDPS, EDS)
- Perturbation with Brownian motion to integrate measurement error
- Optimization approach on NDT measurements